

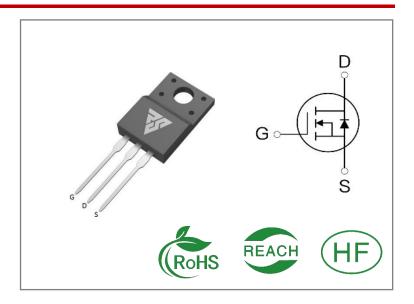
| ID | R _{DS} (ON)(Typ) | VDSS |
|-----|---------------------------|------|
| 13A | 0.36Ω | 500V |

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

| Part Number | Package | Marking | Packing | Qty. |
|-------------|---------|----------|---------|--------|
| RS13N50F | T0-220F | RS13N50F | Tube | 50 PCS |

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

| Symbol | Parameter | RS13N50F | Units |
|----------------|---|------------|---------------|
| VDSS | Drain-to-Source Voltage | 500 | V |
| ID | Continuous Drain Current TC=25℃ | 13 | |
| ID | Continuous Drain Current TC=100℃ | 7.5 | Α |
| IDM | Pulsed Drain Current (Note*1) | 50 | |
| PD | Power Dissipation | 105 | W |
| VGS | Gate- to- Source Voltage | ±30 | V |
| EAS | Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω | 700 | mJ |
| | Maximum Temperature for Soldering | 300 | |
| TL TPKG | Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds | 260 | ${\mathbb C}$ |
| TJ and TSTG | Operating Junction and Storage Temperature Range | -55 to 150 | |

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

| Symbol | Parameter | RS13N50F | Units | Test Conditions |
|--------|-------------------------|----------|-------|--|
| RθJC | Junction-to-Case | 1.14 | | Drain lead soldered to water cooled heatsink, PD adjusted for a peak |
| | | | °C/W | junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$ |
| RθJA | Junction-to- Ambient | 50 | | 1 cubic foot chamber,free air. |

OFF Characteristics TJ= 25[°]C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|--|------|------|------|-------|------------------|
| BVDSS | Drain- to- source Breakdown Voltage | 500 | | | V | VGS=0V,ID=250μA |
| IDSS | Drain- to- Source Leakage Current | | | 1 | μΑ | VDS=500V,VGS=0V |
| ICCC | Gate- to- Source Forward Leakage | | | 100 | ^ | VGS=30V,VDS=0V |
| IGSS | Gate- to- Source Reverse Leakage | 1 | | -100 | nA | VGS=-30V ,VDS=0V |

ON Characteristics TJ=25 °C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|---------|--|------|------|------|-------|----------------------|
| RDS(on) | Static Drain- to- Source On- Resistance(Note*2) | | 0.36 | 0.46 | Ω | VGS=10V,ID=6.5A |
| VGS(TH) | Gate Threshold Voltage | 2 | | 4 | V | VGS=VDS,ID=250μ A |

Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|---------|----------------------|------|------|------|-------|------------------|
| td(ON) | Turn- on Delay Time | | 29 | | | |
| trise | Rise Time | | 58 | | | VDS=250V |
| td(OFF) | Turn- OFF Delay Time | | 58 | | nS | ID=13A RG=25Ω |
| tfall | Fall Time | | 13 | | | |



Dynamic Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|---------------------------------|------|------|------|-------|-----------------|
| Ciss | Input Capacitance | | 2050 | ŀ | | VGS=0V |
| Coss | Output Capacitance | | 182 | - | pF | VDS=25V |
| Crss | Reverse Transfer Capacitance | | 10 | - | | f=1.0MHz |
| Qg | Total Gate Charge | | 43 | - | | VDS=400V |
| Qgs | Gate- to- Source Charge | | 9 | | nC | ID=13A |
| Qgd | Gate-to-Drain(" Miller") Charge | | 16 | - | | VGS=10V |

Source-Drain Diode Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|---------------------------|------|------|------|-------|--------------------------|
| IS | Continuous Source Current | | | 13 | Α | Integral pn- diode in |
| ISM | Maximum Pulsed Current | | - | 50 | Α | MOSFET |
| VSD | Diode Forward Voltage | | 0.8 | 1.2 | V | IS=6.5A,VGS=0V |
| trr | Reverse Recovery Time | | 420 | | nS | VGS=0V |
| Qrr | Reverse Recovery Charge | | 4.4 | | μС | IS=13A, di/dt=100A/μs |

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

Figure 1.Output Characteristics (Tj=25°C)

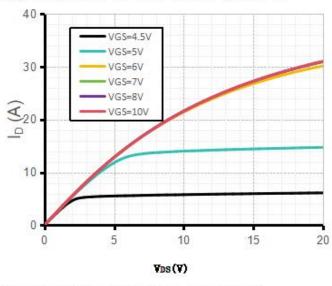


Figure 2. Body Diode Forward Voltage

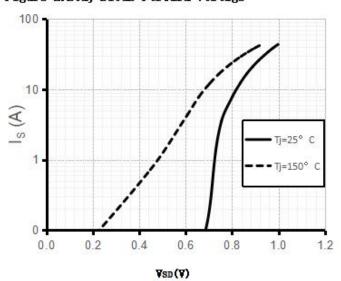


Figure 3. Drain Current vs. Temperature

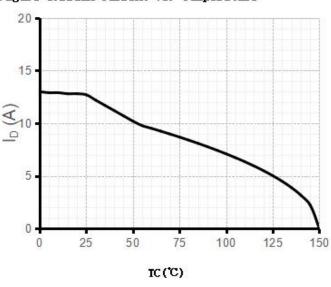


Figure 4.BVDSS Variation vs. Temperature

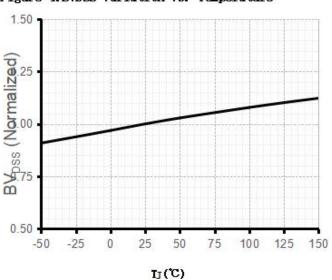


Figure 5. Transfer Characteristics

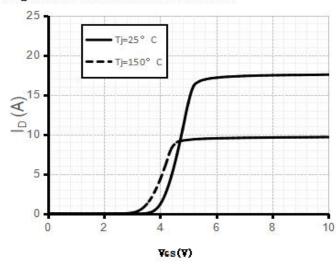
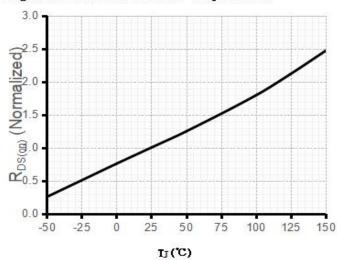


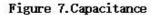
Figure 6.0n-Resistance vs. Temperature



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Typical Feature Curve



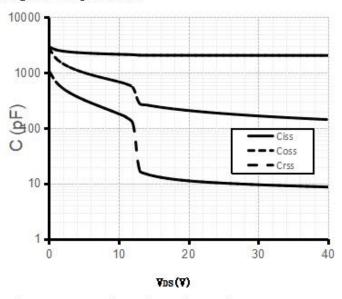


Figure 8. Gate Charge

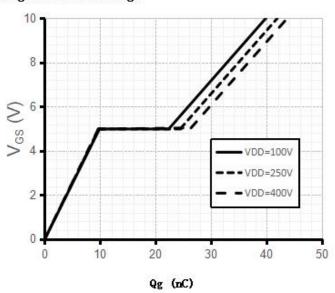


Figure 9. Transient Thermal Impedance

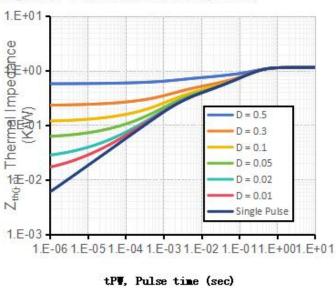
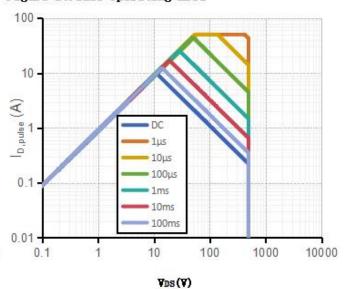


Figure 10. Safe Operating Area





Test Circuits and Waveforms

Figure A: Gate Charge Test Circuit and Waveform

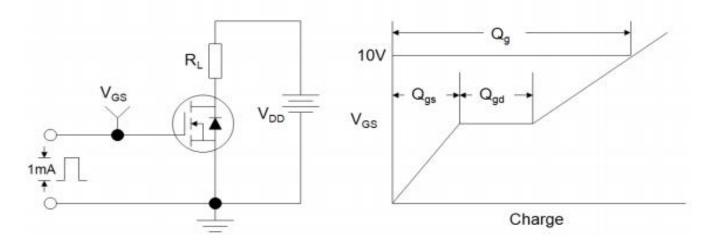


Figure B: Resistive Switching Test Circuit and Waveform

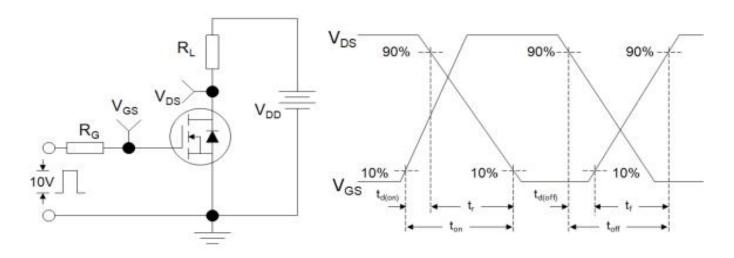
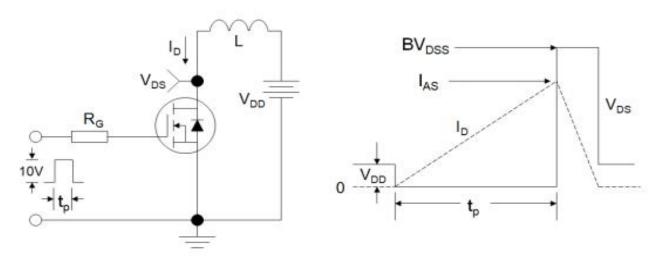


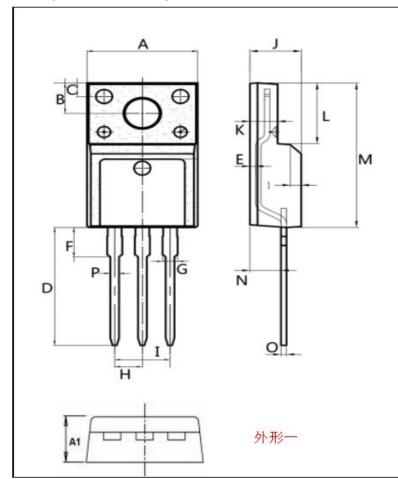
Figure C: Unclamped Inductive Switching Test Circuit and Waveform



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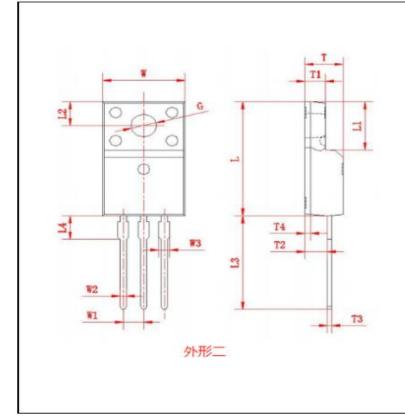


Package outline drawing(TO-220F Unit: mm)



| Min. | Max. |
|-------|---|
| 9.95 | 10.36 |
| 4.5 | 5.0 |
| 2.95 | 3.25 |
| 1.25 | 1.45 |
| 12.60 | 13.60 |
| 0.40 | 0.60 |
| 2.8 | 3.5 |
| 1.30 | 1.45 |
| (2.54 | 1) |
| (5.08 | 3) |
| 4.60 | 4.75 |
| 2.45 | 2.65 |
| 6.5 | 6.8 |
| 15.4 | 16.0 |
| 2.25 | 3.05 |
| 0.45 | 0.55 |
| 0.70 | 0.90 |
| | 9.95 4.5 2.95 1.25 12.60 0.40 2.8 1.30 (2.54 (5.08 4.60 2.45 6.5 15.4 2.25 0.45 |

All Dimensions in millimeter



| Dim. | Min. | Max. | | |
|------|--------|-------|--|--|
| W | 9.95 | 10.36 | | |
| W1 | (2.54) | | | |
| W2 | 0.70 | 0.90 | | |
| W3 | 1.25 | 1.47 | | |
| L | 15.67 | 16.07 | | |
| L1 | 6.48 | 6.88 | | |
| L2 | 3.2 | 3.4 | | |
| L3 | 12.6 | 13.6 | | |
| L4 | (3.23 | 3) | | |
| Т | 4.50 | 4.90 | | |
| T1 | 2.34 | 2.74 | | |
| T2 | 2.25 | 2.95 | | |
| Т3 | 0.45 | 0.60 | | |
| T4 | (0. | .70) | | |
| G | 3.08 | 3.28 | | |



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